Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/012,471	NAKAYAMA ET AL.
Examiner	Art Unit
James M. Hannett	2612

James M. Hannett

SEARCHED				
Class	Subclass	Date	Examiner	
348	262	6/21/2005	ЈМН	
348	218.1	6/21/2005	JMH	
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INTERFERENCE SEARCHED				
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